

March 2013

FQT7N10

N-Channel QFET® MOSFET 100 V, 1.7 A, 350 m Ω

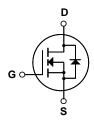
Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 1.7 A, 100 V, $R_{DS(on)}$ =350 m $\Omega(Max.)$ @ V_{GS} =10 V, I_D =0.85 A
- Low Gate Charge (Typ. 5.8 nC)
- Low Crss (Typ. 10 pF)
- 100% Avalanche Tested





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQT7N10	Unit	
V _{DSS}	Drain-Source Voltage		100	V	
I _D	Drain Current - Continuous (T _C = 25°C)		1.7	А	
- Continuous (T _C = 70°C)		°C)	1.36	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	6.8	А	
V _{GSS}	Gate-Source Voltage		± 25	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	50	mJ	
I _{AR}	Avalanche Current	(Note 1)	1.7	А	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	0.2	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns	
P _D	Power Dissipation (T _C = 25°C)		2.0	W	
	- Derate above 25°C		0.016	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	1	62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 100 V, V _{GS} = 0 V			1	μА
		V _{DS} = 80 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 0.85 A		0.28	0.35	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 0.85 A (Note 4)		1.85		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		190 60 10	250 75 13	pF pF
	·			10	10	рі
t _{d(on)}	Ing Characteristics Turn-On Delay Time			7	25	ns
t _r	Turn-On Rise Time	$V_{DD} = 50 \text{ V}, I_{D} = 7.3 \text{ A},$		24	60	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25 \Omega$		13	35	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		19	50	ns
Q _g	Total Gate Charge	V _{DS} = 80 V, I _D = 7.3 A,		5.8	7.5	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 30 \text{ V}, I_D = 7.3 \text{ A},$ $V_{GS} = 10 \text{ V}$		1.4		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		2.5		nC
	<u> </u>	()				
Drain-S	ource Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				1.7	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	um Pulsed Drain-Source Diode Forward Current			6.8	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 1.7 \text{ A}$			1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = 7.3 \text{ A},$		70		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		150		nC

- Notes:
 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 26mH, I $_{AS}$ = 1.74, V $_{DD}$ = 25V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C 3. I $_{SD}$ ≤ 7.3A, di/dt ≤ 300A $_{JLS}$, V $_{DD}$ ≤ BV $_{DSS}$, Starting T $_{J}$ = 25°C 4. Pulse Test : Pulse width ≤ 300 $_{JLS}$, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

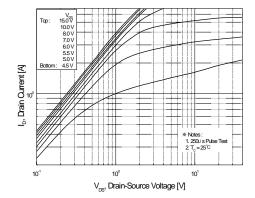


Figure 1. On-Region Characteristics

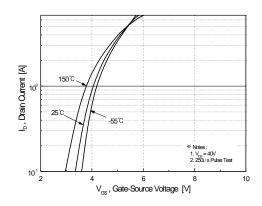


Figure 2. Transfer Characteristics

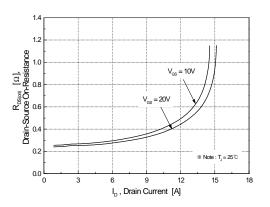


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

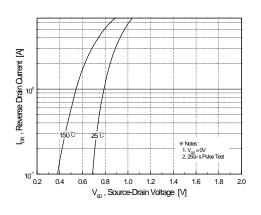


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

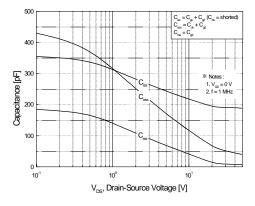


Figure 5. Capacitance Characteristics

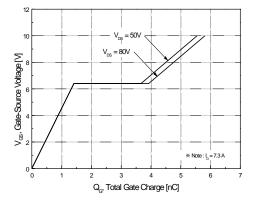
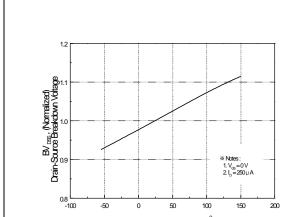


Figure 6. Gate Charge Characteristics



-50

Typical Characteristics (Continued)

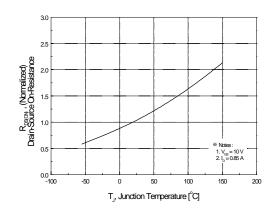
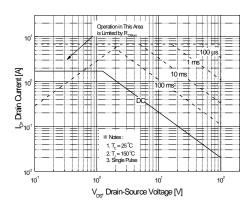


Figure 7. Breakdown Voltage Variation vs. Temperature

T,, Junction Temperature [°C]

150

Figure 8. On-Resistance Variation vs. Temperature



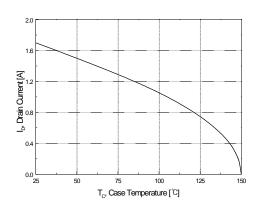


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

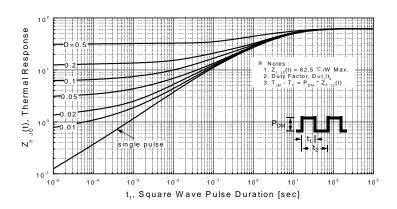
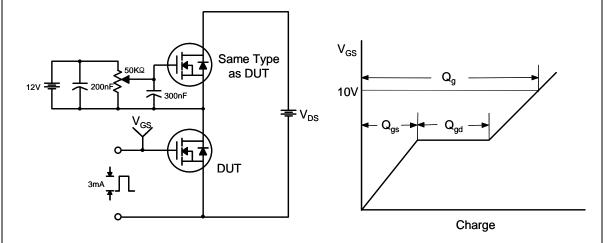
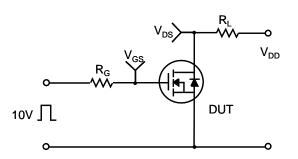


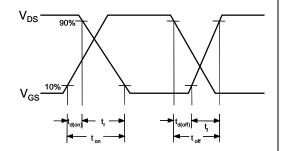
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

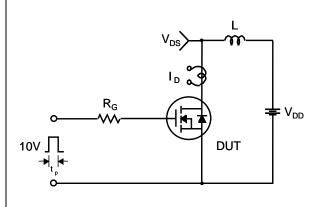


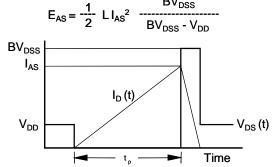
Resistive Switching Test Circuit & Waveforms

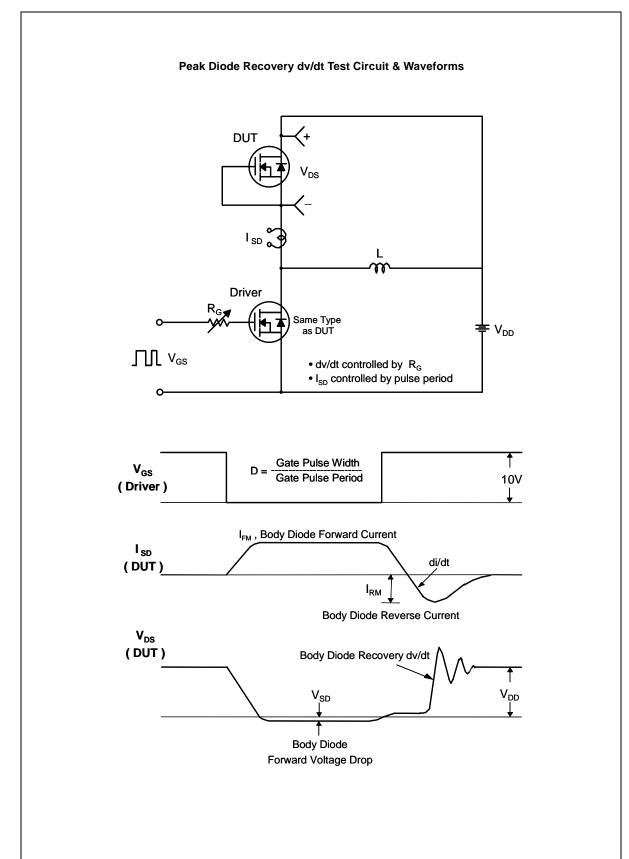


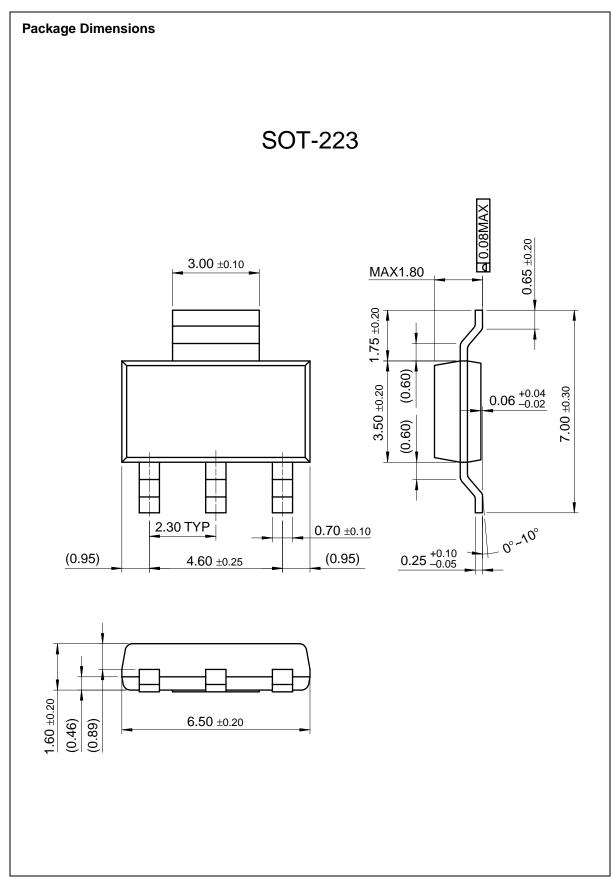


Unclamped Inductive Switching Test Circuit & Waveforms













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